## Application/Control No. Applicant(s)/Patent Under Reexamination 10/814,010 CHANG, WILLIAM I. Notice of References Cited Examiner Art Unit Page 1 of 1 Greg Bengzon 2144 **U.S. PATENT DOCUMENTS Document Number** Date Name Country Code-Number-Kind Code Classification MM-YYYY \* US-2006/0041505 A1 02-2006 Enyart, Robert A. Α 705/040 US-2003/0163485 A1 08-2003 В Goodwin et al. 707/104.1 US-2002/0032602 A1 03-2002 С Lanzillo et al. 705/14 US-2002/0099605 A1 07-2002 Weitzman et al. D 705/14 US-2007/0083438 A1 Ε 04-2007 Coleman, Thomas E. 705/026 US-2005/0055321 A1 Fratkina et al. 03-2005 F 706/045 US-7,085,745 B2 08-2006 Klug, John R. G 705/401 US-6,708,205 B2 03-2004 Sheldon et al. Н 709/206 \* US-2003/0233419 A1 12-2003 Beringer, Joerg Т 709/206 \* US-2002/0120702 A1 08-2002 J Schiavone et al. 709/207 \* US-2005/0004837 A1 01-2005 Κ Sweeney et al. 705/014 US-L US-M FOREIGN PATENT DOCUMENTS **Document Number** Date Country Country Code-Number-Kind Code Name Classification MM-YYYY N O Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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